

U.S. Department of Commerce, Patent and Trademark Office (PTO Form 1449 modified)		Docket No. SEA/3369	Serial No.
LIST OF PATENTS AND PUBLICATIONS CITED BY APPLICANT		Applicant Shih-Fu Lee	Confirmation No.: _____
(Use several sheets if necessary)		Filing Date	Group
Examiner			

**U.S. Patent Documents**

*Examiner Initial		Document Number	Issue Date	Applicant(s) Name	Class	Subclass	Filing Date If Appropriate
KJW	A1	6,618,215 B2	09-09-2003	Fung, et al.	360	31	03-06-2002
	A2	6,615,387 B1	09-02-2003	Williamson, et al.	714	785	09-02-2003
	A3	6,611,397 B1	08-26-2003	Nguyen, H.V.	360	77.08	06-04-1999
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	A7	6,587,293 B1	07-01-2003	Ding, et al.	360	51	02-29-2000
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	A10	6,476,995 B1	11-05-2002	Liu, et al.	360	75	01-14-2000
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	A12	6,404,590 B1	06-11-2002	Kuo, et al.	360	135	03-18-1998
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**Foreign Patent Documents**

*Examiner Initial	Document Number	Date	Country	Class	Subclass	Translation	
						YES	NO
	B1					<input type="checkbox"/>	<input type="checkbox"/>
	B2					<input type="checkbox"/>	<input type="checkbox"/>

**OTHER ART**

*Examiner Initial		Including Author, Title, Date, Pertinent Pages, Etc.
	C1	ECE Signals and Systems Fall, 2002, UMD, "Experiment 2: The Controls in the Spectrum Analyzer," 8 pages
	C2	"Spectrum Analyzer Updates," June 10, 2000, 15 pages
	C3	J. Mulder, "An RMS-DC Converter Based on the Dynamic Translinear Principle," IEEE Journal of Solid-State Circuits, Vol. 32, No. 7, July 1997, Pages 1146-1150

Examiner	<i>Kewei Li</i>	Date Considered <u>3/3/05</u>
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with your communication to applicant.		

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**Foreign Patent Documents**

*Examiner Initial		Document Number	Date	Country	Class	Subclass	Translation	
							YES	NO
	B3						<input type="checkbox"/>	<input type="checkbox"/>
	B4						<input type="checkbox"/>	<input type="checkbox"/>
	B5						<input type="checkbox"/>	<input type="checkbox"/>
	B6						<input type="checkbox"/>	<input type="checkbox"/>

**OTHER ART**

*Examiner Initial		Including Author, Title, Date, Pertinent Pages, Etc.
	C4	"RF Up/Down Conversion Is Simplified By Linear Arrays", Intersil™, Application Note 9744, July 1997, 4 pages
	C5	<a href="http://whatis.techtarget.com/definition">http://whatis.techtarget.com/definition</a> , 2 pages
	C6	

Examiner  Date Considered 3/3/05

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